

Search Notes**Application/Control No.**

10/560,281

Examiner

Karen Cheng

Applicant(s)/Patent under Reexamination

TACHIBANA ET AL.

Art Unit

1626

SEARCHED

Class	Subclass	Date	Examiner
548	320.1	5/9/2007	KC
514	391	5/9/2007	KC
560	129	5/9/2007	KC
560	303	5/9/2007	KC

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STN Structure Search (updated, see attached)	5/9/2007	KC
EAST Search (see attached)	5/9/2007	KC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
514	391	5/9/2007	KC
548	320.1	5/9/2007	KC
560	129, 303	5/9/2007	KC